4 Megabit

 $(512K \times 8)$ 

**CMOS EPROM** 

**OTP** 

#### **Features**

- Fast Read Access Time 80 ns
- Low Power CMOS Operation
  100 μA max. Standby

30 mA max. Active at 5 MHz

JEDEC Standard Packages

32-Lead 600-mil PDIP

32-Lead 450-mil SOIC (SOP) 32-Lead PLCC

32-Lead TSOP

● 5V ± 10% Supply

High Reliability CMOS Technology
 2000V ESD Protection

2000V ESD Protection
200 mA Latchup Immunity

- Rapid<sup>™</sup> Programming Algorithm 100 µs/byte (typical)
- CMOS and TTL Compatible Inputs and Outputs
- Integrated Product Identification Code
- Commercial and Industrial Temperature Ranges

## Description

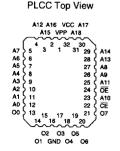
The AT27C040 chip is a low-power, high-performance 4,194,304 bit one-time programmable read only memory (OTP EPROM) organized as 512K by 8 bits. The AT27C040 requires only one 5V power supply in normal read mode operation. Any byte can be accessed in less than 80 ns, eliminating the need for speed reducing WAIT states on high-performance microprocessor systems.

Atmel's scaled CMOS technology provides low active power consumption, and fast programming. Power consumption is typically 8 mA in active mode and less than 10  $\mu\text{A}$  in standby mode.

(continued)

## **Pin Configurations**

Pin Name	Function
A0 - A18	Addresses
00 - 07	Outputs
CE	Chip Enable
ŌĒ	Output Enable



PDIP, SOIC Top View

VPP 🗆	1	32	vcc
A16 🗆	2		
A15 🗆	2 3 4	30	□ A17
A12	4	29	□ A14
A7 🗆	5	28	□ A13
A6 ∐	6	27	□ A8
A5 🗆		26	□ A9
A4 🗆	7 8 9	25	□ A11
A3 📮	9	24	Þ ŌĒ
A7 U U U U U U U U U U U U U U U U U U U	10	29 28 27 26 25 24 23	A10 CE D 07
A1 ☐	11	22	□ ĈĒ
A0 🗆	12	22 21	D 07
∞□	13	20	□ 06
	14	20 19	A18 A17 A14 A13 A8 A9 A11 D DE D OF D OF D OF D OF D OF D OF D OF D OF
O2 🗆	15 16	18	D 04
GND 🗆	16	17	<b>□ 03</b>

TSOP Top View

A11		$\overline{}$	4				h		~
	A9 🗆	10	•	2	32	31	Б	A10	UE
A8		1	3	-	30	31	Б	~10	OE CE
	A13 5	4	Ė			29	Þ	07	
A14		1	5		28		P		06
	A17 5	6	_			27	Þ	O5	
A18	vcc 🗄	1 .	7		26		В		Q4
VPP	VUU :	8	۰		•	25	ĸ.	03	
VEC	A16	10	•		24		Ĕ.	02	GND
415		3	1	1	22	23	Ħ	UZ.	
	A12 ⊆	12	•	•	22	21	Б	00	01
A7		4	1:	3	20		ь		A0
	A6 □	14			20	19	Ь	A1	AU
A5		1	15	5	18		ь		A2
	A4 C	16				17	Þ	АЗ	~~

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## **Description** (Continued)

The AT27C040 is available in a choice of industry standard JEDEC-approved one-time programmable (OTP) plastic PDIP, PLCC, SOIC (SOP), and TSOP packages. The device features two-line control (CE, OE) to eliminate bus contention in high-speed systems.

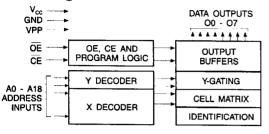
Atmel's AT27C040 has additional features to ensure high quality and efficient production use. The Rapid<sup>™</sup> Programming Algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100 µs/byte. The Integrated Product Identification Code electronically identifies the device and manufacturer. This feature is used by industry standard programming equipment to select the proper programming algorithms and voltages.

#### **System Considerations**

Switching between active and standby conditions via the Chip Enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed data sheet limits, resulting in device non-conformance. At a minimum, a 0.1 µF high frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the Vcc and Ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a 4.7 µF bulk electrolytic capacitor should be utilized, again connected between the Vcc and Ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.

AT27C040

## **Block Diagram**



## **Absolute Maximum Ratings\***

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +150°C
Voltage on Any Pin with Respect to Ground2.0V to +7.0V (1)
Voltage on A9 with Respect to Ground2.0V to +14.0V <sup>(1)</sup>
VPP Supply Voltage with Respect to Ground2.0V to +14.0V (1)

\*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note: 1. Minimum voltage is -0.6V dc which may undershoot to - 2.0V for pulses of less than 20 ns. Maximum output pin voltage is V<sub>CC</sub> + 0.75V dc which may overshoot to +7.0V for pulses of less than 20 ns.

## **Operating Modes**

Mode \ Pin	CE	ŌĒ	Ai	VPP	Outputs
Read	V <sub>IL</sub>	VIL	Ai	X <sup>(1)</sup>	Douт
Output Disable	Х	VIH	X	Х	High Z
Standby	ViH	Х	X	Х	High Z
Rapid Program (2)	VIL	ViH	Ai	V <sub>PP</sub>	DIN
PGM Verify	X	VIL	Ai	VPP	Dout
PGM Inhibit	ViH	V <sub>IH</sub>	Х	V <sub>PP</sub>	High Z
Product Identification (4)	V <sub>IL</sub>	VIL	A9 = V <sub>H</sub> <sup>(3)</sup> A0 = V <sub>IH</sub> or V <sub>IL</sub> A1 - A18 = V <sub>IL</sub>	х	Identification Code

Notes: 1. X can be VIL or VIH.

- 2. Refer to Programming characteristics.
- 3.  $V_H = 12.0 \pm 0.5 V$ .

4. Two identifier bytes may be selected. All Ai inputs are held low (V<sub>IL</sub>), except A9 which is set to V<sub>H</sub> and A0 which is toggled low (V<sub>IL</sub>) to select the Manufacturer's Identification byte and high (V<sub>IH</sub>) to select the Device Code byte.





## **DC and AC Operating Conditions for Read Operation**

		AT27C040						
		-80	-10	-12	-15			
Operating	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C	0°C - 70°C			
Temperature (Case)	Ind.	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C			
Vcc Power Supply		5V ± 5%	5V ± 10%	5V ± 10%	5V ± 10%			

## **DC and Operating Characteristics for Read Operation**

Symbol	Parameter	Condition	Min	Max	Units
lu	Input Load Current	VIN = 0V to VCC		±1	μΑ
İLO	Output Leakage Current	Vout = 0V to Vcc		±5	μА
IPP1 (2)	V <sub>PP</sub> <sup>(1)</sup> Read/Standby Current	V <sub>PP</sub> = V <sub>CC</sub>		10	μА
ISB	Vcc <sup>(1)</sup> Standby Current	I <sub>SB1</sub> (CMOS), $\overline{\text{CE}}$ = V <sub>CC</sub> ± 0.3V		100	μА
ISB VCC Starioby	VCC Standby Current	I <sub>SB2</sub> (TTL), $\overline{CE}$ = 2.0 to V <sub>CC</sub> + 0.5V		1	mA
Icc	Vcc Active Current	$\frac{f = 5 \text{ MHz}, I_{OUT} = 0 \text{ mA},}{CE} = V_{IL}$		30	mA
V <sub>IL</sub>	Input Low Voltage		-0.6	0.8	٧
ViH	Input High Voltage		2.0	Vcc + 0.5	٧
Vol	Output Low Voltage	lo <sub>L</sub> = 2.1 mA		0.4	٧
Vон	Output High Voltage	IOH = -400 μA	2.4		V

Notes: 1. V<sub>CC</sub> must be applied simultaneously or before V<sub>PP</sub>, and removed simultaneously or after V<sub>PP</sub>.

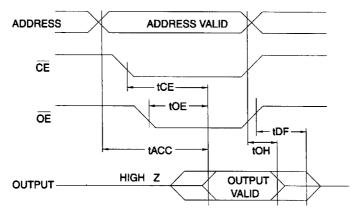
## **AC Characteristics for Read Operation**

			AT27C040								
			-	80	_	10		12		15	
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Min	Мах	Units
tacc (3)	Address to Output Delay	CE = OE = V <sub>IL</sub>		80		100		120		150	ns
tce (2)	CE to Output Delay	OE = V <sub>IL</sub>		80		100		120		150	ns
toE (2, 3)	OE to Output Delay	CE = VIL		35		35		35		40	ns
t <sub>DF</sub> <sup>(4, 5)</sup>	OE or CE High to Output Float, whicheve	er occurred first		30		30		30		30	ns
tон	Output Hold from Addr CE or OE, whichever of	ess.	0		0		0		0		ns

Notes: 2, 3, 4, 5. - see AC Waveforms for Read Operation.

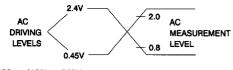
VPP may be connected directly to V<sub>CC</sub>, except during programming. The supply current would then be the sum of I<sub>CC</sub> and I<sub>PP</sub>.

## **AC Waveforms for Read Operation** (1)



- Notes: 1. Timing measurement references are 0.8V and 2.0V.
  Input AC drive levels are 0.45V and 2.4V, unless
  otherwise specified.
  - DE may be delayed up to toe toe after the falling edge of CE without impact on toe.
  - 3. OE may be delayed up to tACC tOE after the address is valid without impact on tACC.
- 4. This parameter is only sampled and is not 100% tested.
- Output float is defined as the point when data is no longer driven.

## Input Test Waveforms and Measurement Levels



t<sub>R</sub>, t<sub>F</sub> < 20 ns (10% to 90%)

## **Output Test Load**



Note: CL = 100 pF including jig capacitance.

## Pin Capacitance (f = 1 MHz, T = 25°C) (1)

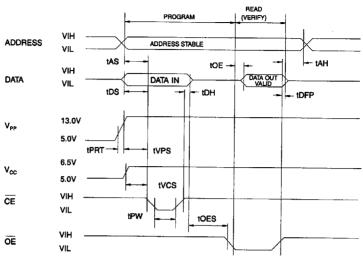
	Тур	Max	Units	Conditions	
CIN	4	8	pF	V <sub>IN</sub> = 0V	
Cout	8	12	pF	Vout = 0V	

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.





## **Programming Waveforms** (1)



- Notes: 1. The Input Timing Reference is 0.8V for  $V_{IL}$  and 2.0V for  $V_{IH}$ .
  - 2. to and to propriet are characteristics of the device but must be accommodated by the programmer.
- When programming the AT27C040 a 0.1 μF capacitor is required across Vpp and ground to suppress spurious voltage transients.

# **DC Programming Characteristics**

 $T_A = 25 \pm 5$ °C,  $V_{CC} = 6.5 \pm 0.25$ V,  $V_{PP} = 13.0 \pm 0.25$ V

		Test	t		
Symbol	Parameter	Conditions	Min	Max	Units
Li	Input Load Current	$V_{IN} = V_{IL}, V_{IH}$		±10	μА
VIL	Input Low Level		-0.6	0.8	٧
ViH	Input High Level		2.0	V <sub>CC</sub> + 0.7	٧
VoL	Output Low Voltage	loL = 2.1 mA		0.4	V
Vон	Output High Voltage	Iон = -400 µA	2.4		V
lcc2	V <sub>CC</sub> Supply Current (Program and Verify)			40	mA
IPP2	VPP Supply Current	CE = V <sub>IL</sub>		20	mA
$V_{1D}$	A9 Product Identification Voltage		11.5	12.5	٧

## **AC Programming Characteristics**

 $T_A = 25 \pm 5$ °C,  $V_{CC} = 6.5 \pm 0.25$ V,  $V_{PP} = 13.0 \pm 0.25$ V

Sym-	Parameter	Test Conditions* (1)	<b>Li</b> r Min	nits Max	Units
tas	Address Setup T	ime	2	max	μs
toes	OE Setup Time				μЅ
tos	Data Setup Time		2		μS
tah	Address Hold Tir	ne	0		μS
tDH	Data Hold Time		2		μS
tDFP	OE High to Outp	ut	0	130	ns
tvps	VPP Setup Time		2		μS
tvcs	V <sub>CC</sub> Setup Time		2		μS
tpw	CE Program Pul	se Width <sup>(3)</sup>	95	105	μS
toe	Data Valid from 0	DE <sup>(2)</sup>		150	ns
tPRT	V <sub>PP</sub> Pulse Rise 1 Programming	ime During	50		ns

#### \*AC Conditions of Test:

Input Rise and Fall Times (10% to	90%)20 ns
Input Pulse Levels	
Input Timing Reference Level	0.8V to 2.0V
Output Timing Reference Level	0.8V to 2.0V

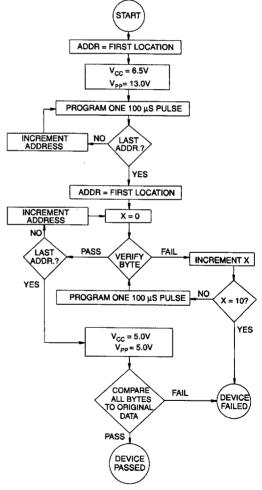
- Notes: 1. Vcc must be applied simultaneously or before VPP and removed simultaneously or after VPP.
  - 2. This parameter is only sampled and is not 100% tested. Output Float is defined as the point where data is no longer driven -see timing diagram.
  - 3. Program Pulse width tolerance is 100 usec ± 5%.

## Atmel's 27C040 Integrated **Product Identification Code**

	Pins				Hex					
Codes	ΑO	07	<b>O</b> 6	<b>O</b> 5	04	О3	02	01	00	Data
Manufacturer	0	0	0	0	1	1	1	1	0	1E
Device Type	1	0	0	0	0	1	0	1	1	OB

## Rapid Programming Algorithm

A 100 µs CE pulse width is used to program. The address is set to the first location. Vcc is raised to 6.5V and Vpp is raised to 13.0V. Each address is first programmed with one 100 µs CE pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive 100 µs pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked. Vpp is then lowered to 5.0V and Vcc to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.







# **Ordering Information**

tacc	Icc (mA)						
(ns)	Active	Standby	Ordering Code	Package	Operation Range		
80	30	0.1	AT27C040-80JC AT27C040-80PC AT27C040-80RC AT27C040-80TC	32J 32P6 32R 32T	Commercial (0°C to 70°C)		
	30	0.1	AT27C040-80JI AT27C040-80PI AT27C040-80RI AT27C040-80TI	32J 32P6 32R 32T	Industrial (-40°C to 85°C)		
100	30	0.1	AT27C040-10JC AT27C040-10PC AT27C040-10RC AT27C040-10TC	32J 32P6 32R 32T	Commercial (0°C to 70°C)		
	30	0.1	AT27C040-10JI AT27C040-10PI AT27C040-10RI AT27C040-10TI	32J 32P6 32R 32T	Industrial (-40°C to 85°C)		
120	30 .	0.1	AT27C040-12JC AT27C040-12PC AT27C040-12RC AT27C040-12TC	32J 32P6 32R 32T	Commercial (0°C to 70°C)		
	30	0.1	AT27C040-12JI AT27C040-12PI AT27C040-12RI AT27C040-12TI	32J 32P6 32R 32T	Industrial (-40°C to 85°C)		
150	30	0.1	AT27C040-15JC AT27C040-15PC AT27C040-15RC AT27C040-15TC	32J 32P6 32R 32T	Commercial (0°C to 70°C)		
	30	0.1	AT27C040-15JI AT27C040-15PI AT27C040-15RI AT27C040-15TI	32J 32P6 32R 32T	Industrial (-40°C to 85°C)		

Package Type				
32J	32 Lead, Plastic J-Leaded Chip Carrier (PLCC)			
32P6	32 Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)			
32R	32 Lead, 0.450" Wide, Plastic Gull Wing Small Outline (SOIC)			
32T	32 Lead, Plastic Thin Small Outline Package (TSOP)			